Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,513	WU ET AL.	
Examiner	Art Unit	
Hoai-An D. Nguyen	2858	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Consulted with Primary Examiner A. Deb.	9/29/2005	HADN
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